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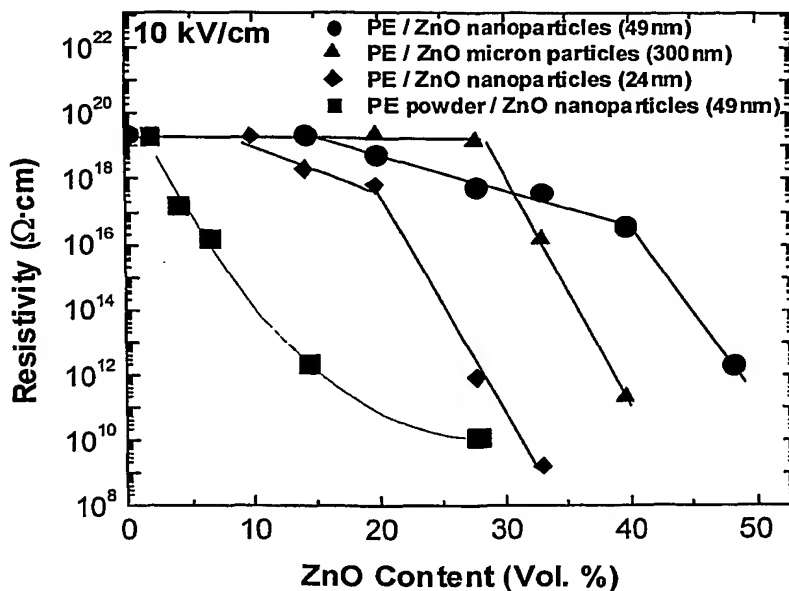
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(54) Title: NANOCOMPOSITES WITH CONTROLLED ELECTRICAL PROPERTIES



(57) Abstract: A field grading material
includes a field grading effective amount
of a nanoparticle filler distributed in a
polymeric matrix, and the nanoparticle
filler is heterogeneously distributed in the
polymeric matrix.

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